

Search Notes

Application/Control No.

10/534,275

Examiner

Daniel Lai

Applicant(s)/Patent under
Reexamination

HOSHINO ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	69 70 506	4/21/2007	DL
455	504 505	4/27/2007	DL
455	63.4 226.3	4/27/2007	DL
455	522	4/27/2007	DL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference Search Printout		4/27/2007	DL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Keyword search (see search history)	4/21/2007	DL
limited class/subclass search (see search history)	4/21/2007	DL
Consulted with SPE for search help	4/21/2007	DL
Consulted with SPE for allowance	4/26/2007	DL